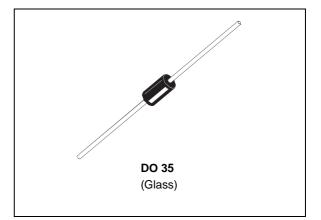


BAT46

SMALL SIGNAL SCHOTTKY DIODE



DESCRIPTION

General purpose, metalto silicon diode featuring high breakdown voltage low turn-on voltage.

ABSOLUTE RATINGS (limiting values)

Symbol	Parameter		Value	Unit
V _{RRM}	Repetitive Peak Reverse Voltage		100	V
IF	Forward Continuous Current* T _a = 25	5°C	150	mA
I _{FRM}	$\label{eq:response} \begin{array}{l} \mbox{Repetitive Peak Forward Current}^{*} & t_p \leq 1 \mbox{s} \\ \delta \leq 0.5 \end{array}$		350	mA
I _{FSM}	Surge non Repetitive Forward Current* $t_p = 10$	ms	750	mA
P _{tot}	Power Dissipation* T _I = 80)°C	150	mW
T _{stg} Tj	Storage and Junction Temperature Range		- 65 to + 150 - 65 to + 125	°C
TL	Maximum Temperature for Soldering during 10s at 4mm from Case		230	°C

THERMAL RESISTANCE

Symbol	Test Conditions	Value	Unit
R _{th(j-a)}	Junction-ambient*	300	°C/W

* On infinite heatsink with 4mm lead length.

ELECTRICAL CHARACTERISTICS

STATIC CHARACTERISTICS

Symbol	Test Conditions		Min.	Тур.	Max.	Unit
V _{BR}	$T_j = 25^{\circ}C$	I _F = 10μΑ	100			V
V _F *	$T_j = 25^{\circ}C$	I _F = 0.1mA			0.25	V
	$T_j = 25^{\circ}C$	I _F = 10mA			0.45	
	$T_j = 25^{\circ}C$	I _F = 250mA			1	
I _R *	$T_j = 25^{\circ}C$	V _R = 1.5V			0.5	μA
	$T_j = 60^{\circ}C$				5	
	$T_j = 25^{\circ}C$	V _R = 10V			0.8	
	$T_j = 60^{\circ}C$				7.5	
	T _j = 25°C	$V_R = 50V$			2	
	$T_j = 60^{\circ}C$				15	
	$T_j = 25^{\circ}C$	$V_R = 75V$			5	
	$T_j = 60^{\circ}C$				20	

DYNAMIC CHARACTERISTICS

Symbol	Test Conditions			Min.	Тур.	Max.	Unit
С	$T_j = 25^{\circ}C$	$V_R = 0V$	f = 1Mhz		10		pF
	$T_j = 25^{\circ}C$	$V_R = 1V$			6		

* Pulse test: $t_p\!\leq\!300\mu s~\delta\!<\!2\%$.

57

Fig. 1-1: Forward voltage drop versus forward current (low level, typical values)

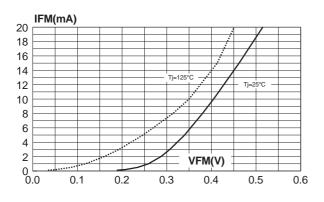


Fig. 2: Leakage current versus reverse voltage applied (typical values)

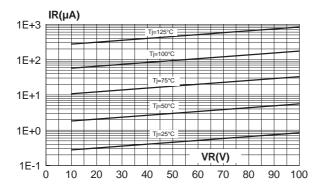


Fig. 4: Junction capacitance versus reverse voltage applied (typical values)

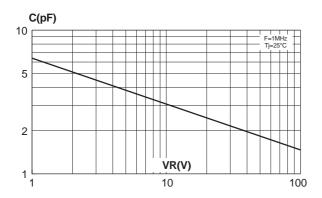


Fig. 1-2: Forward voltage drop versus forward current (high level, typical values)

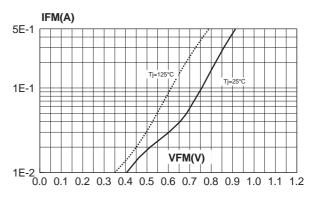
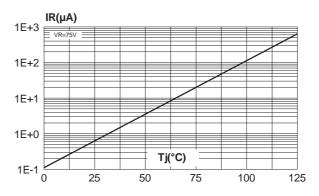


Fig. 3: Leakage current versus junction temperature (typical values)

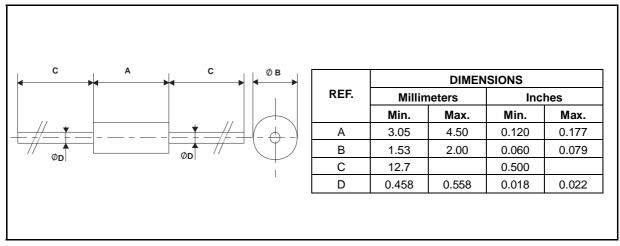




BAT46

PACKAGE MECHANICAL DATA

DO 35 Glass



Cooling method : by convection and conduction Marking: clear, ring at cathode end. Weight: 0.15g

Information furnished is believed to be accurate and reliable. However, STMicroelectronics assumes no responsibility for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of STMicroelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. STMicroelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of STMicroelectronics.

The ST logo is a registered trademark of STMicroelectronics

© 1999 STMicroelectronics - Printed in Italy - All rights reserved.

STMicroelectronics GROUP OF COMPANIES

Australia - Brazil - China - Finland - France - Germany - Hong Kong - India - Italy - Japan - Malaysia Malta - Morocco - Singapore - Spain - Sweden - Switzerland - United Kingdom - U.S.A.

http://www.st.com

Ĺ**Ţ**